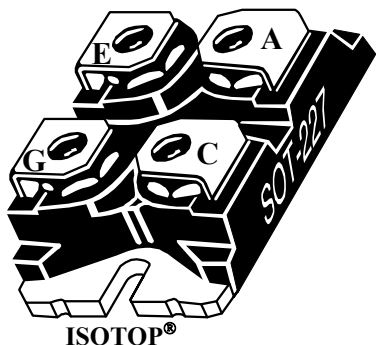
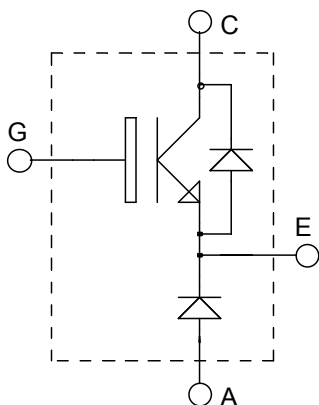


**ISOTOP® Buck chopper  
NPT IGBT**
 $V_{CES} = 600V$   
 $I_C = 60A @ T_c = 95^{\circ}C$ 

**Application**

- AC and DC motor control
- Switched Mode Power Supplies

**Features**

- Non Punch Through (NPT) THUNDERBOLT IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 100 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- ISOTOP® Package (SOT-227)
- Very low stray inductance
- High level of integration

**Benefits**

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive  $T_C$  of  $V_{CESat}$
- RoHS Compliant

**Absolute maximum ratings**

Symbol	Parameter			Max ratings	Unit
$V_{CES}$	Collector - Emitter Breakdown Voltage			600	V
$I_{C1}$	Continuous Collector Current		$T_C = 25^{\circ}C$	93	A
$I_{C2}$			$T_C = 95^{\circ}C$	60	
$I_{CM}$	Pulsed Collector Current		$T_C = 25^{\circ}C$	360	
$V_{GE}$	Gate – Emitter Voltage			$\pm 20$	V
$P_D$	Maximum Power Dissipation		$T_C = 25^{\circ}C$	378	W
$I_{LM}$	RBSOA clamped Inductive load Current	$R_G = 11\Omega$	$T_C = 25^{\circ}C$	360	A
$I_{FV}$	Maximum Average Forward Current	Duty cycle=0.5	$T_C = 80^{\circ}C$	30	A
$I_{FRMS}$	RMS Forward Current (Square wave, 50% duty)			39	


**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

**All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified**

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$BV_{CES}$	Collector - Emitter Breakdown Voltage	$V_{GE} = 0V, I_C = 0.5mA$	600			V
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V$ $V_{CE} = 600V$			80 2000	$\mu A$
$V_{CE(on)}$	Collector Emitter on Voltage	$V_{GE} = 15V$ $I_C = 60A$		2.0	2.5 2.8	V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 500\mu A$	3	4	5	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = \pm 20V, V_{CE} = 0V$			$\pm 100$	nA

**Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0V$		3125	3590	pF
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$		310	450	
$C_{res}$	Reverse Transfer Capacitance	$f = 1MHz$		180	310	
$Q_g$	Total gate Charge	$V_{GS} = 15V$		257	410	nC
$Q_{ge}$	Gate – Emitter Charge	$V_{Bus} = 300V$		19	30	
$Q_{gc}$	Gate – Collector Charge	$I_C = 60A$		120	180	
$T_{d(on)}$	Turn-on Delay Time	Resistive Switching ( $25^\circ\text{C}$ )		20	40	ns
$T_r$	Rise Time	$V_{GE} = 15V$		95	190	
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 300V$		315	470	
$T_f$	Fall Time	$I_C = 60A$ $R_G = 5\Omega$		245	490	
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $25^\circ\text{C}$ )		26	50	ns
$T_r$	Rise Time	$V_{GE} = 15V$		63	125	
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 400V$		395	590	
$T_f$	Fall Time	$I_C = 60A$ $R_G = 5\Omega$		68	140	
$E_{ts}$	Total switching Losses			3.4	7	mJ
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $150^\circ\text{C}$ )		25	50	ns
$T_r$	Rise Time	$V_{GE} = 15V$		59	120	
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 400V$		430	650	
$T_f$	Fall Time	$I_C = 60A$ $R_G = 5\Omega$		65	130	
$E_{on}$	Turn-on Switching Energy			1.6	3.2	mJ
$E_{off}$	Turn-off Switching Energy			2.4	4.8	
$E_{ts}$	Total switching Losses			4.0	8.0	

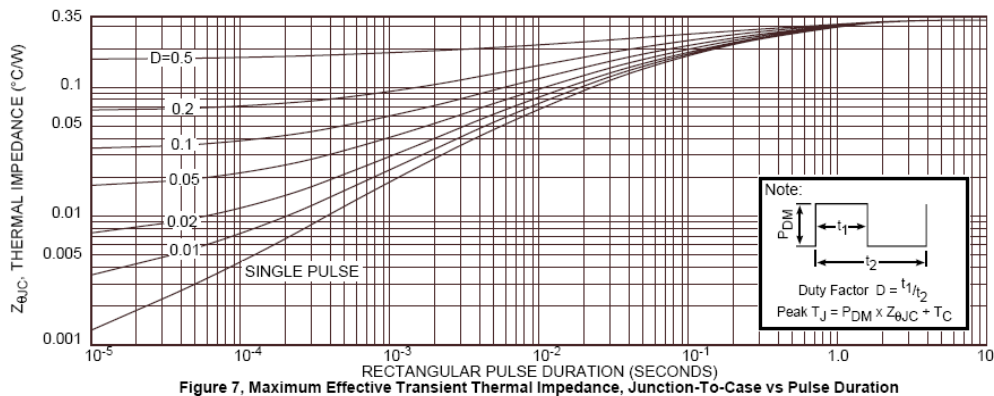
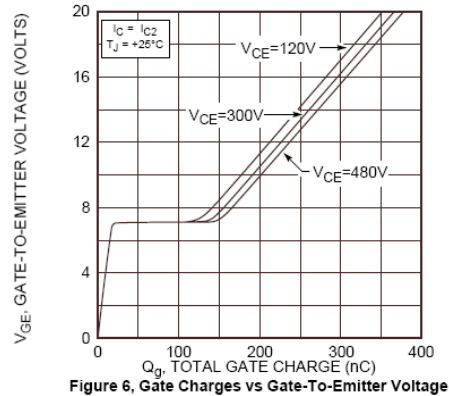
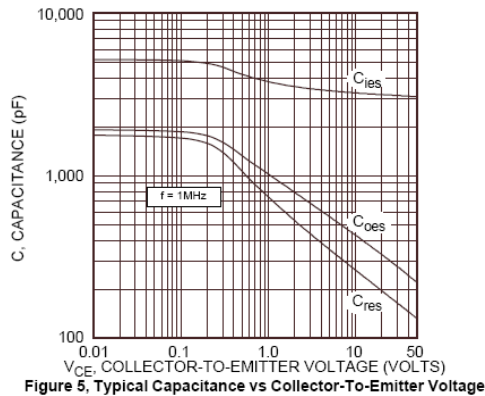
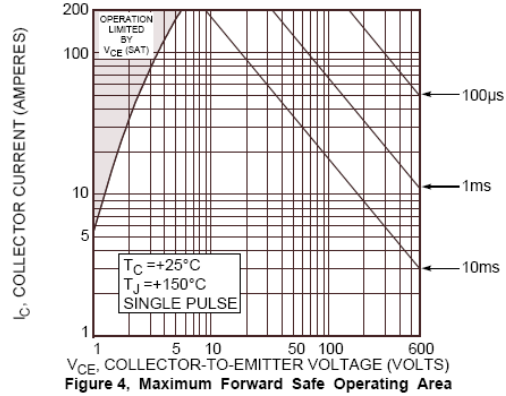
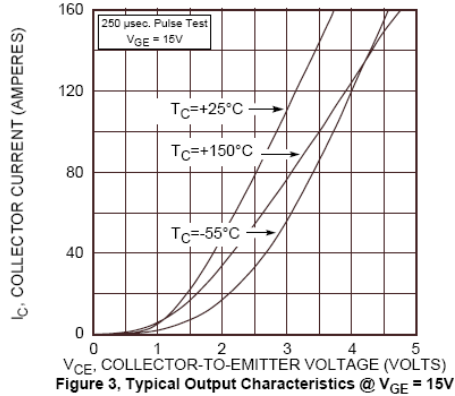
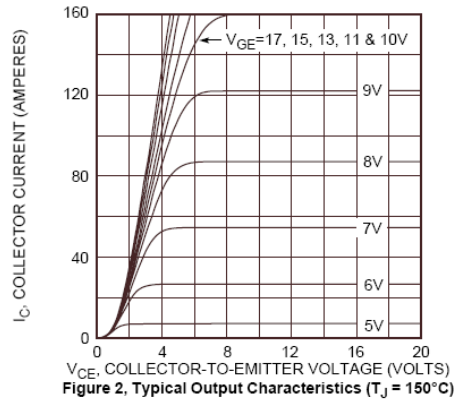
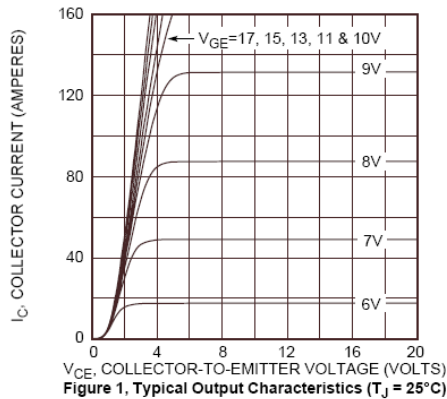
**Chopper code ratings and characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 30A		1.6	1.8	V
		I <sub>F</sub> = 60A		1.9		
		I <sub>F</sub> = 30A    T <sub>j</sub> = 125°C		1.4		
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> = 600V    T <sub>j</sub> = 25°C			250	μA
		V <sub>R</sub> = 600V    T <sub>j</sub> = 125°C			500	
C <sub>T</sub>	Junction Capacitance	V <sub>R</sub> = 200V		44		pF
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 1A, V <sub>R</sub> = 30V di/dt = 100A/μs    T <sub>j</sub> = 25°C		23		ns
	Reverse Recovery Time	I <sub>F</sub> = 30A V <sub>R</sub> = 400V di/dt = 200A/μs	T <sub>j</sub> = 25°C	85		
			T <sub>j</sub> = 125°C	160		
I <sub>RRM</sub>	Maximum Reverse Recovery Current	I <sub>F</sub> = 30A V <sub>R</sub> = 400V di/dt = 200A/μs	T <sub>j</sub> = 25°C	4		A
			T <sub>j</sub> = 125°C	8		
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 30A V <sub>R</sub> = 400V di/dt = 200A/μs	T <sub>j</sub> = 25°C	130		nC
			T <sub>j</sub> = 125°C	700		
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 30A		70		ns
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>R</sub> = 400V		1300		nC
I <sub>RRM</sub>	Maximum Reverse Recovery Current	di/dt = 1000A/μs		30		A

**Thermal and package characteristics**

Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>thJC</sub>	Junction to Case	IGBT			0.33	°C/W
		Diode			1.21	
R <sub>thJA</sub>	Junction to Ambient (IGBT & Diode)				20	
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz		2500			V
T <sub>J</sub> , T <sub>STG</sub>	Storage Temperature Range		-55		150	°C
T <sub>L</sub>	Max Lead Temp for Soldering: 0.063" from case for 10 sec				300	
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m
Wt	Package Weight			29.2		g

## Typical IGBT Performance Curve



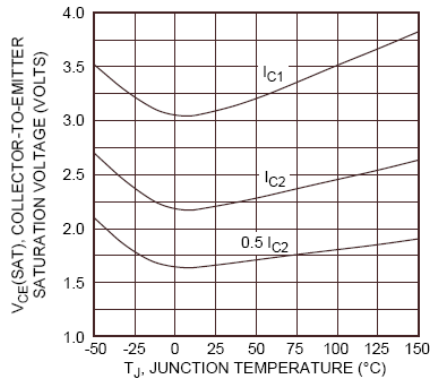


Figure 8, Typical  $V_{CE(SAT)}$  Voltage vs Junction Temperature

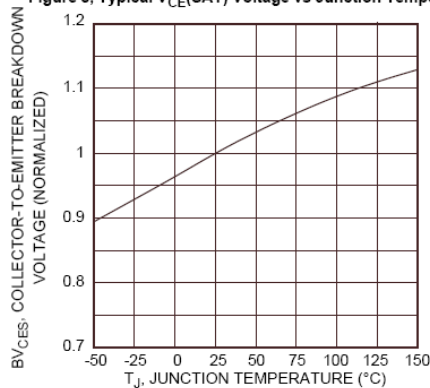


Figure 10, Breakdown Voltage vs Junction Temperature

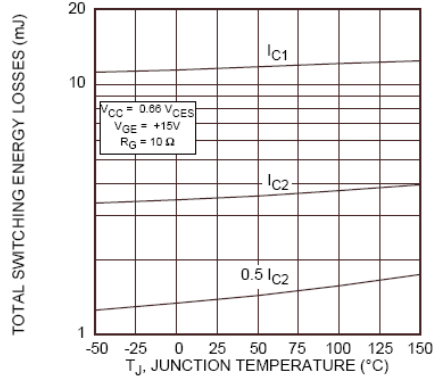


Figure 12, Typical Switching Energy Losses vs. Junction Temperature

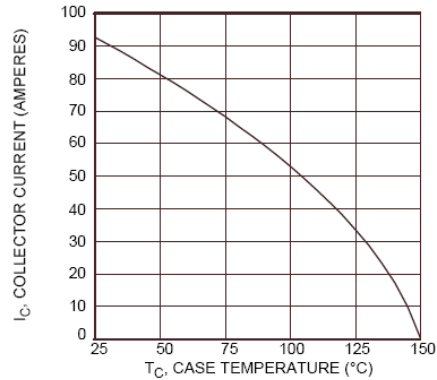


Figure 9, Maximum Collector Current vs Case Temperature

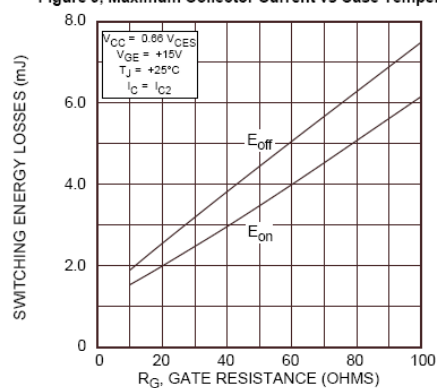


Figure 11, Typical Switching Energy Losses vs Gate Resistance

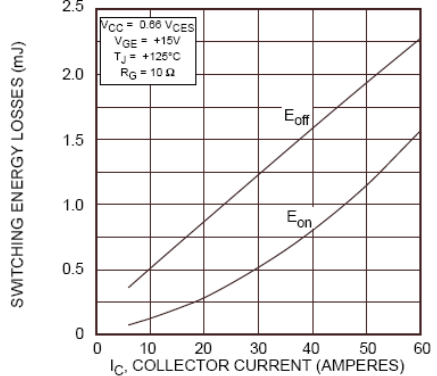


Figure 13, Typical Switching Energy Losses vs Collector Current

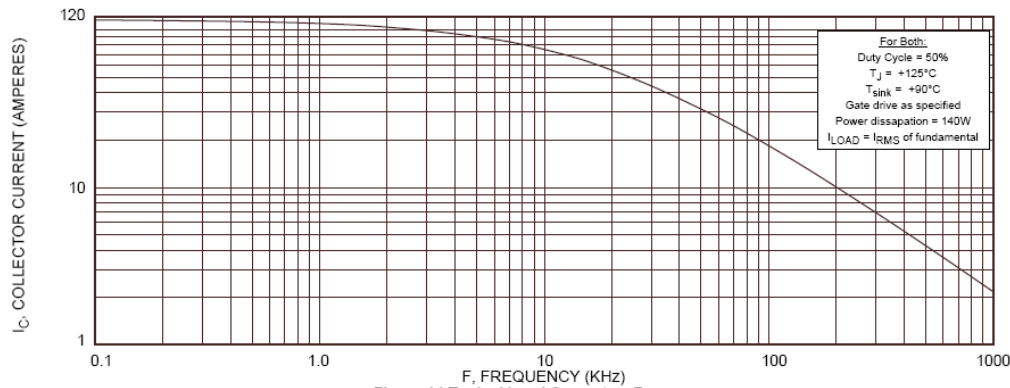


Figure 14, Typical Load Current vs Frequency

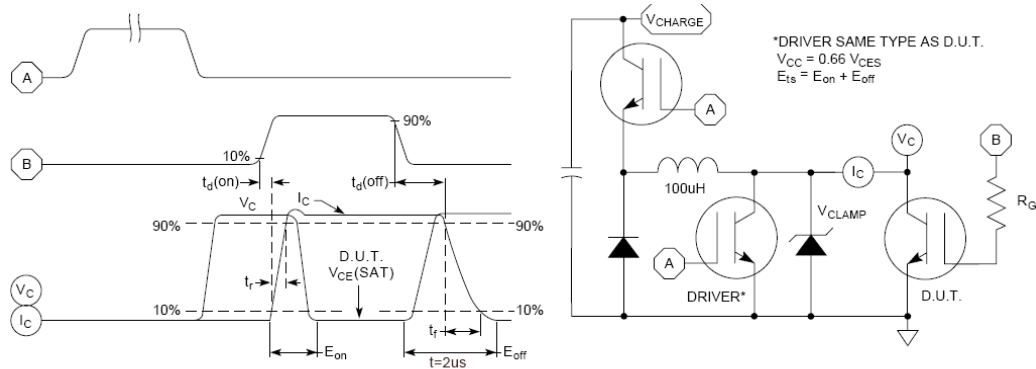


Figure 15, Switching Loss Test Circuit and Waveforms

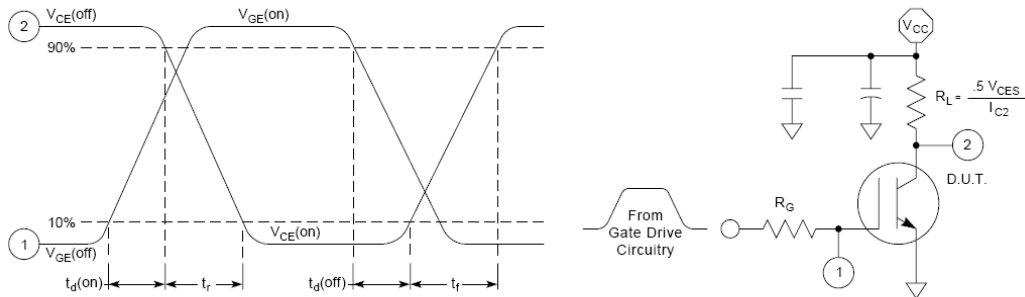


Figure 16, Resistive Switching Time Test Circuit and Waveforms

## Typical Diode Performance Curve

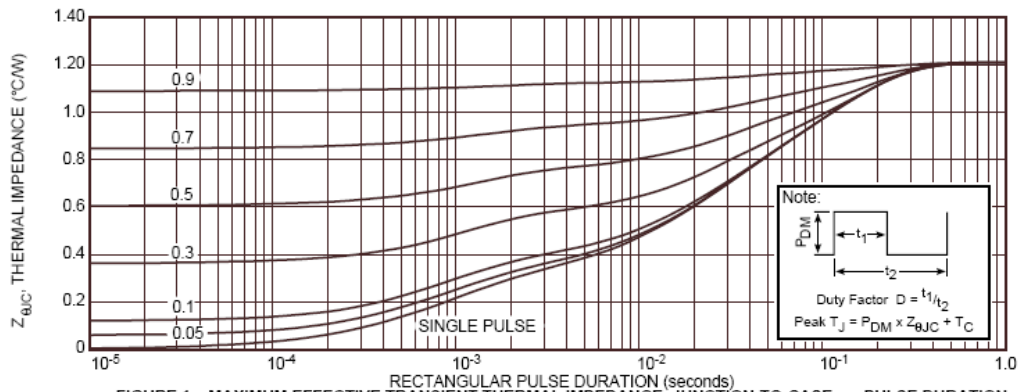


FIGURE 1a. MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs. PULSE DURATION

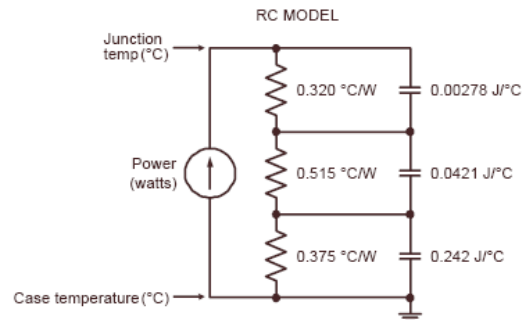


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL

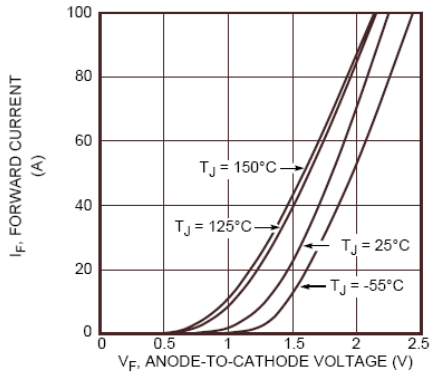


Figure 2. Forward Current vs. Forward Voltage

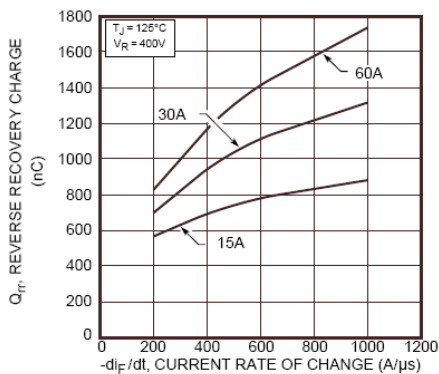


Figure 4. Reverse Recovery Charge vs. Current Rate of Change

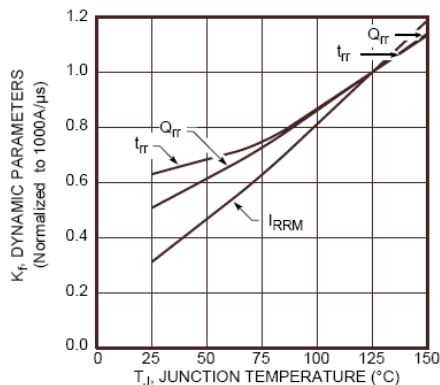


Figure 6. Dynamic Parameters vs. Junction Temperature

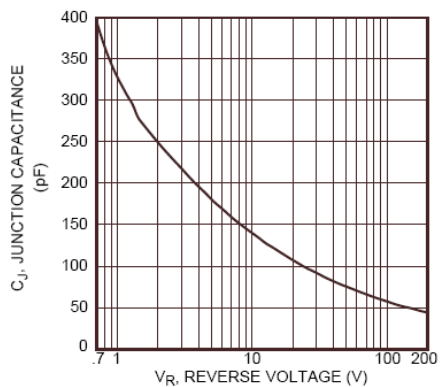


Figure 8. Junction Capacitance vs. Reverse Voltage

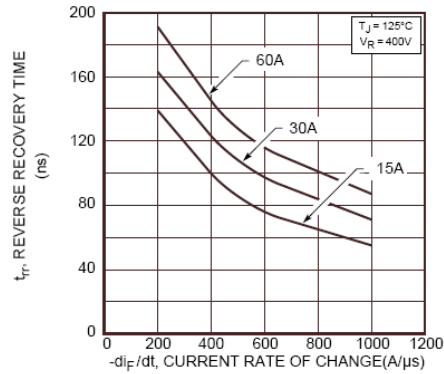


Figure 3. Reverse Recovery Time vs. Current Rate of Change

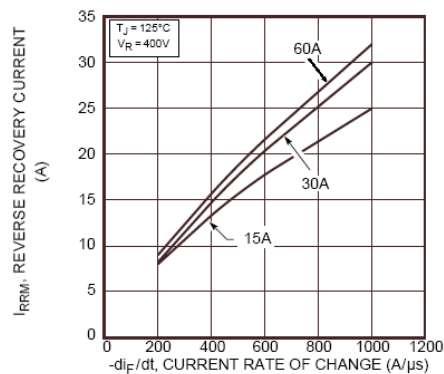


Figure 5. Reverse Recovery Current vs. Current Rate of Change

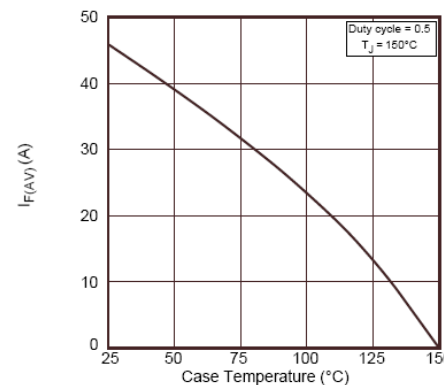


Figure 7. Maximum Average Forward Current vs. Case Temperature

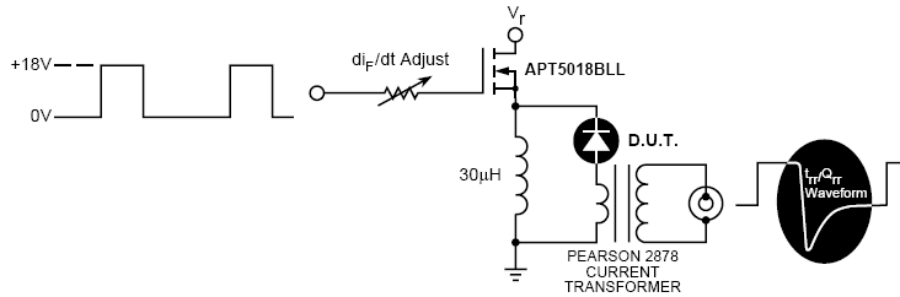


Figure 9. Diode Test Circuit

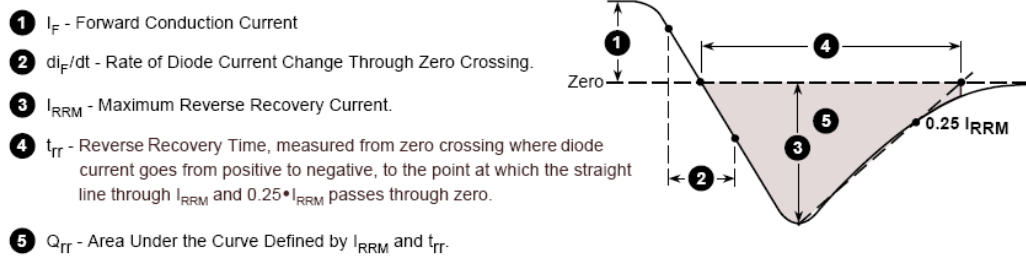
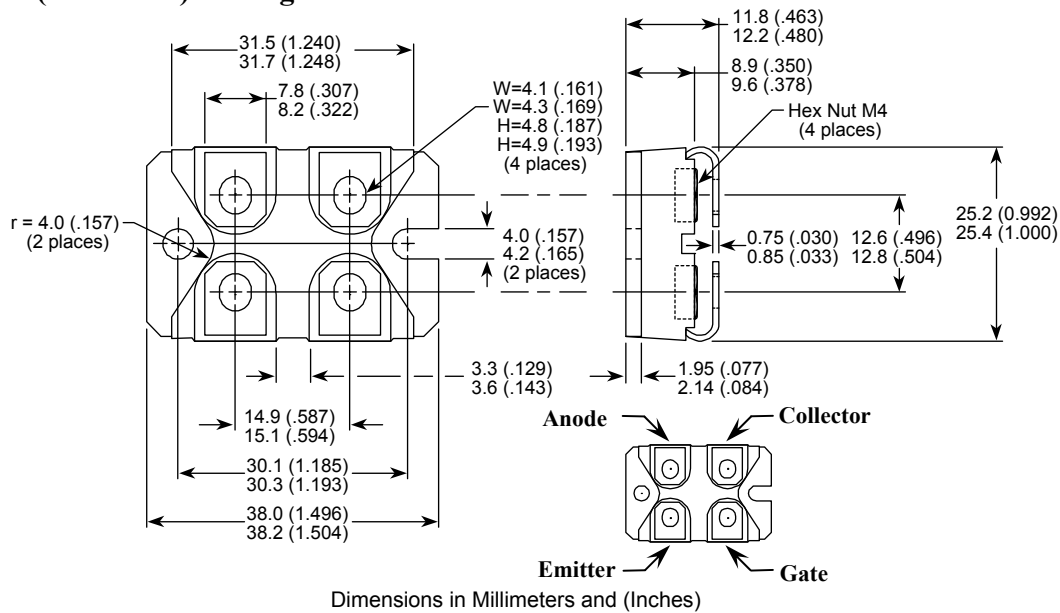


Figure 10. Diode Reverse Recovery Waveform and Definitions

## SOT-227 (ISOTOP®) Package Outline



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